

ETH zürich

Advanced Measurement Technology for Power Electronics Systems

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ETH Zurich, Switzerland

PCIM
SOUTH AMERICA

Keynote



Agenda

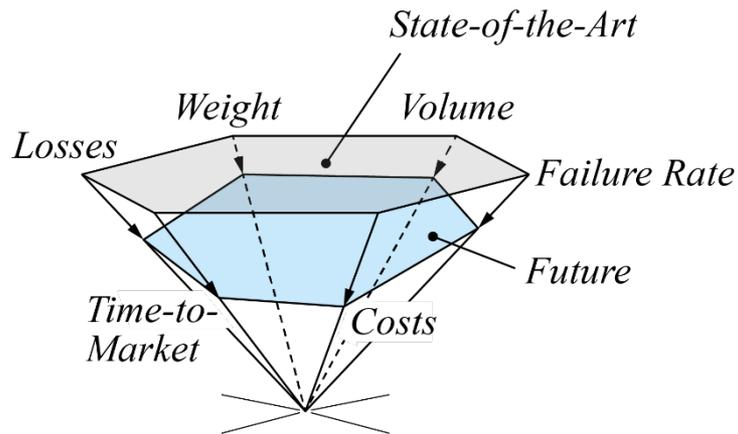
Introduction	Measuring Today: Componets	Measuring Today: System	Measuring in the Future	Summary Outlook
13 slides	27 slides	9 slides	13 slides	1

Introduction

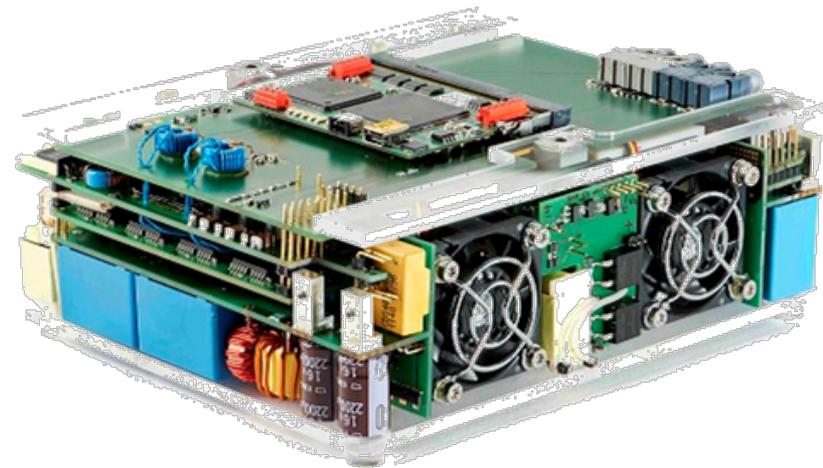
*Power electronics' designer goal
Typical and future power electronics
measurement situations*

► Power Electronics Engineer Goal

- Design a power electronic system which complies with a certain set performance indices



Source: Ch. Gammeter
Converter for airborne wind turbine

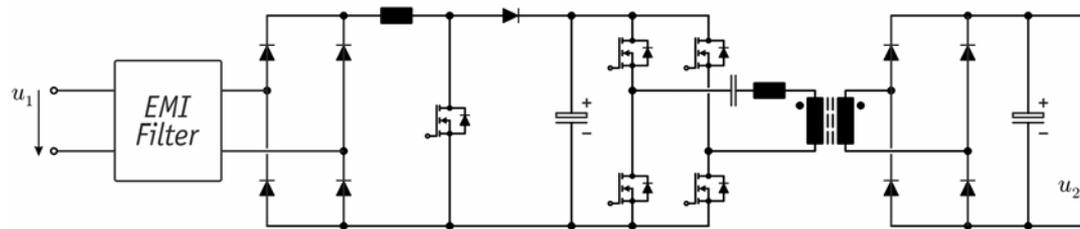


- Performance Indices

- Power density [kW/dm³]
- Power per unit weight [kW/kg]
- Relative costs [kW/\$]
- Relative losses [%]
- Failure rate [h⁻¹]

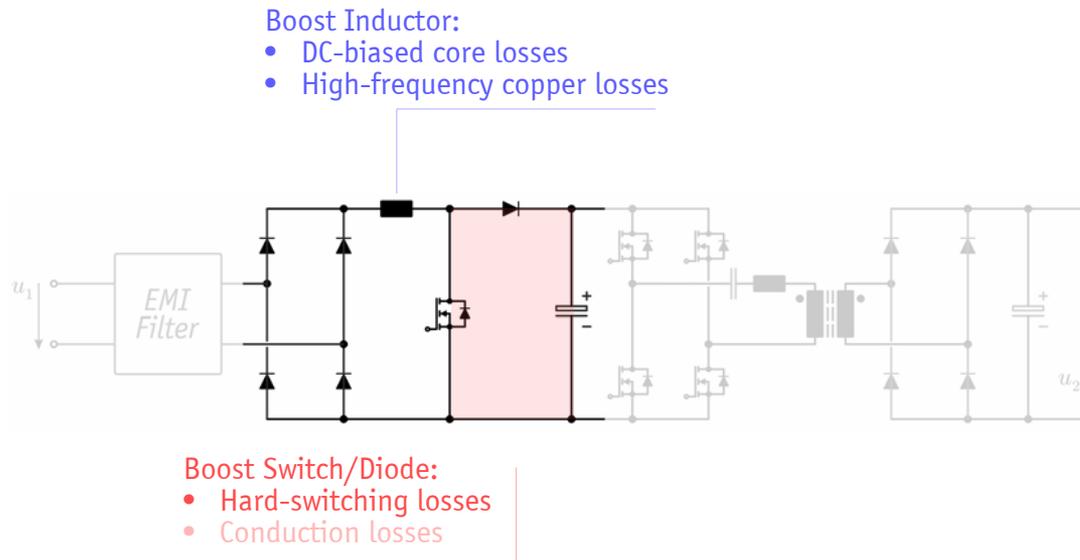
► Assessing System's Performance

- Translation of system requirements into components' requirements
- Example: boost-type PFC rectifier with resonant-type isolation DC-DC converter stage



► Assessing System's Performance

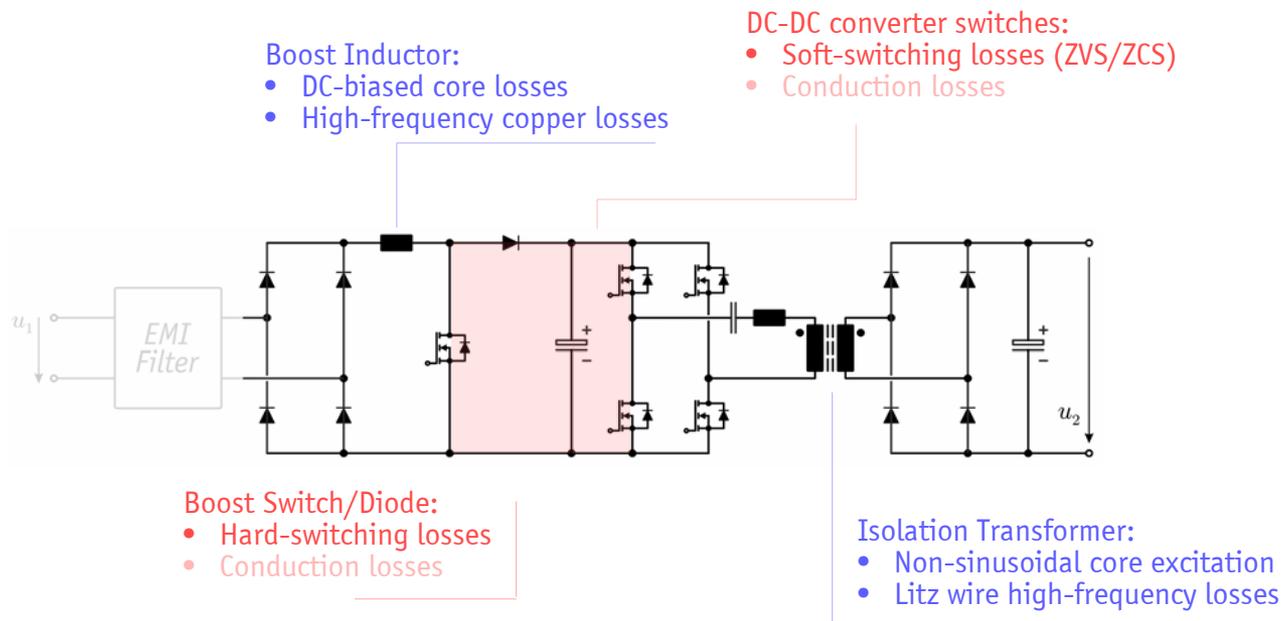
- Translation of system requirements into components' requirements
- Example: boost-type PFC rectifier with resonant-type isolation DC-DC converter stage
- Boost-type rectifier



► Assessing System's Performance

- Translation of system requirements into components' requirements
- Example: boost-type PFC rectifier with resonant-type isolation DC-DC converter stage

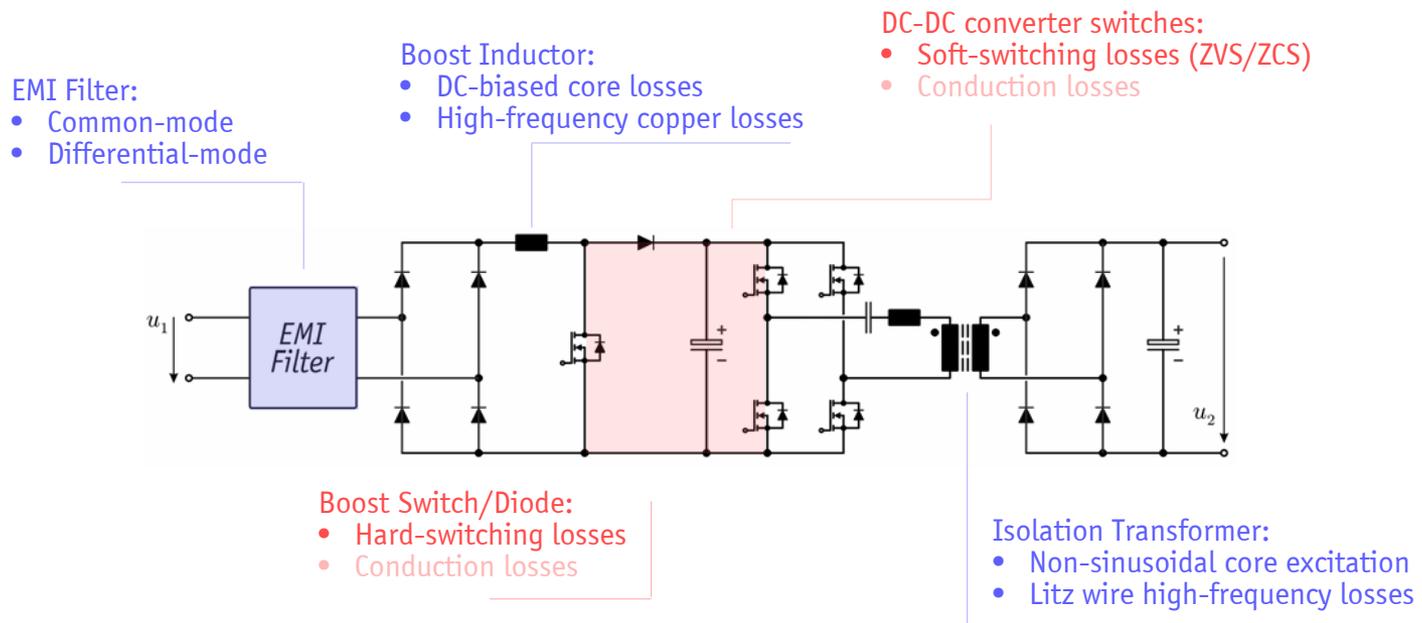
- Boost-type rectifier
- Isolated DC-DC converter



► Assessing System's Performance

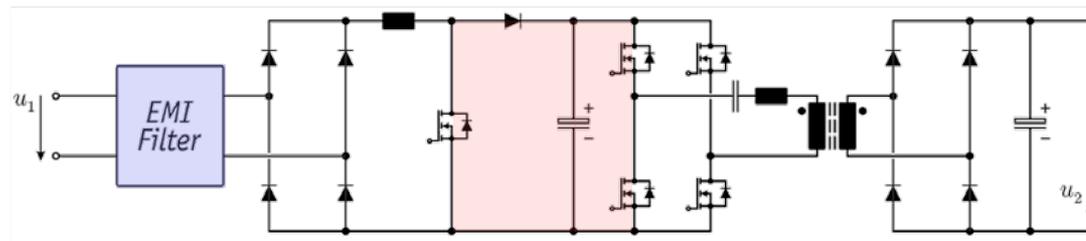
- Translation of system requirements into components' requirements
- Example: boost-type PFC rectifier with resonant-type isolation DC-DC converter stage

- Boost-type rectifier
- Isolated DC-DC converter
- EMI Filter



► Assessing System's Performance

- Translation of system requirements into components' requirements
- Example: boost-type PFC rectifier with resonant-type isolation DC-DC converter stage
- Boost-type rectifier
- Isolated DC-DC converter
- EMI Filter
- **Efficiency**



Input power



Output power

Power losses

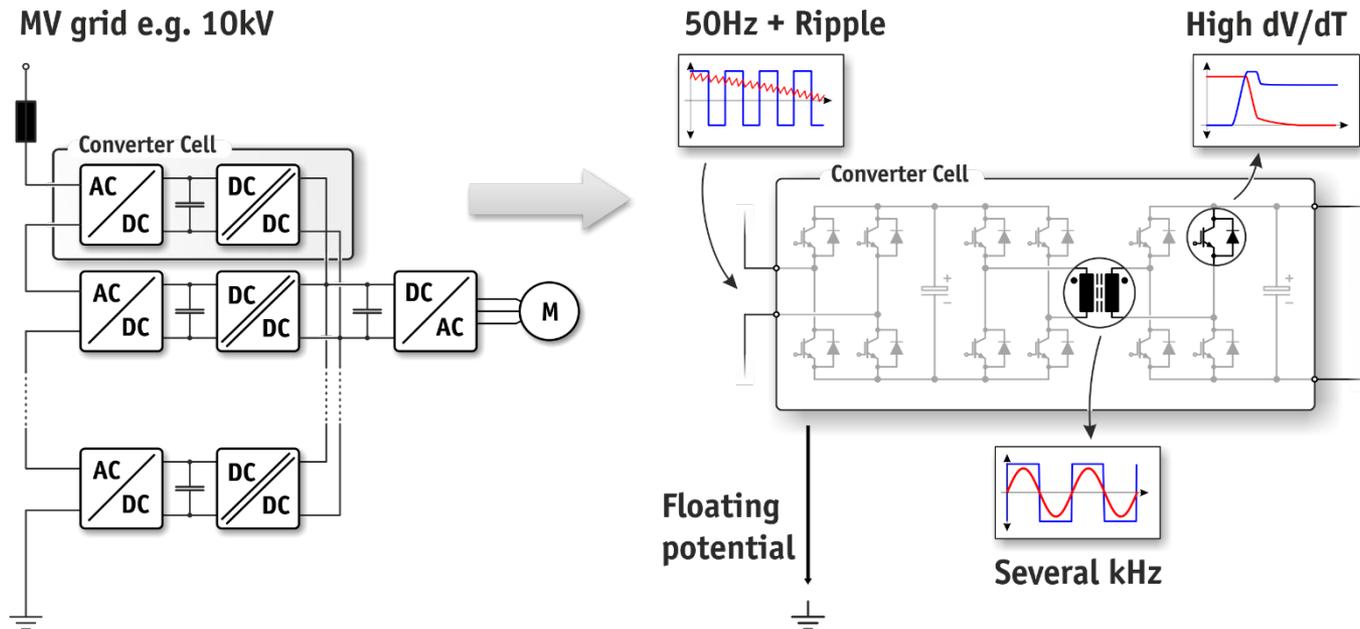
- **The performance of the complete system is defined by the performance of its individual components**

Introduction

*Power electronics' designer goal
Typical and future power electronics
measurement situations*

► Future Traction Vehicles Based on SST Technology

- Typical measurements performed during testing and commissioning of power electronic converters



- **Floating potentials:** Up to tens of kilovolts and tens of kilovolts/microsecond
- **Voltages / currents:** From millivolts to kilovolts, from amps to kiloamps, **DC to tens of MHz**

► Future Micro Power Electronic Solutions

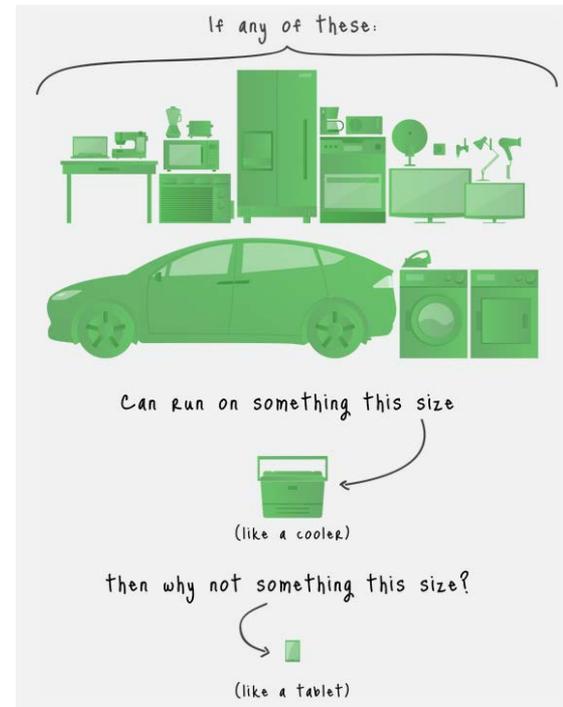
- Vicor highly integrated power supplies
- The little box challenge

Up to 1750W (!)
Isolated DC-DC converter



www.vicorpower.com

www.littleboxchallenge.com



INTRODUCING THE LITTLE BOX CHALLENGE

- Big challenges during testing and debugging of the converter system!

► Today, Soon, and Future of Power Electronics...

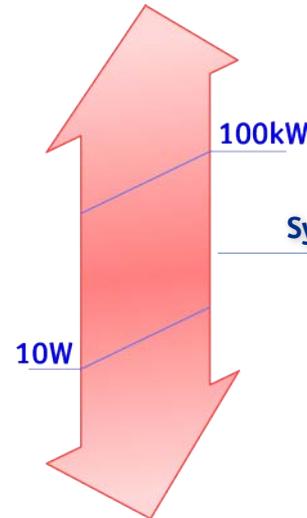
- Today:

System Applications

Standard / integrated solutions

MV / MF Power
Electronics

Smart microgrids
DC Distribution



100kW

System Applications Standard / integrated
solutions

10W

Micro Power
Electronics

Microelectronics technology
Power supply on chip

► Today, Soon, and Future of Power Electronics...

- Today: System Applications Standard / integrated solutions



MV / MF Power Electronics

Smart microgrids
DC Distribution

100kW

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Micro Power Electronics

Microelectronics technology
Power supply on chip

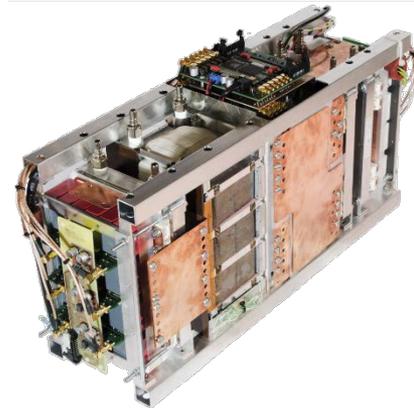
- Future (Soon): Medium Freq. Medium Volt. Smart microgrids, DC distribution

► Today, Soon, and Future of Power Electronics...

- Today:

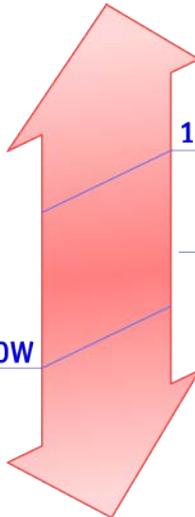
System Applications

Standard / integrated solutions



MV / MF Power
Electronics

Smart microgrids
DC Distribution



100kW

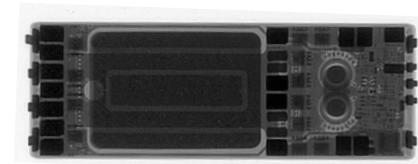
System Applications

Standard / integrated
solutions

10W

Micro Power
Electronics

Microelectronics technology
Power supply on chip



- Future (Soon):

Medium Freq. Medium Volt.

Smart microgrids, DC distribution

- Future:

Micro Power Electronics

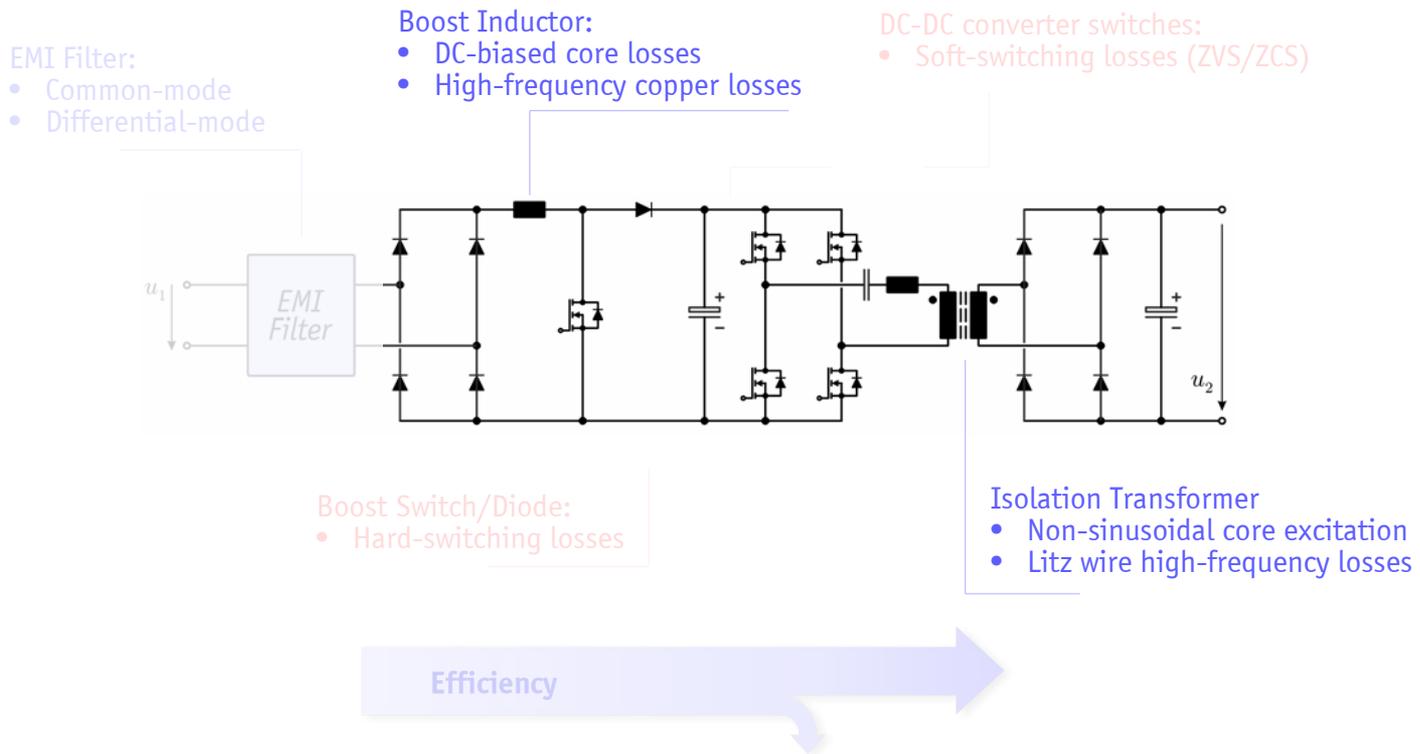
Microelectronics technology, power supply on chip

Today's Measurement Concepts

...in power electronic systems:
Passive components
Active components
System level

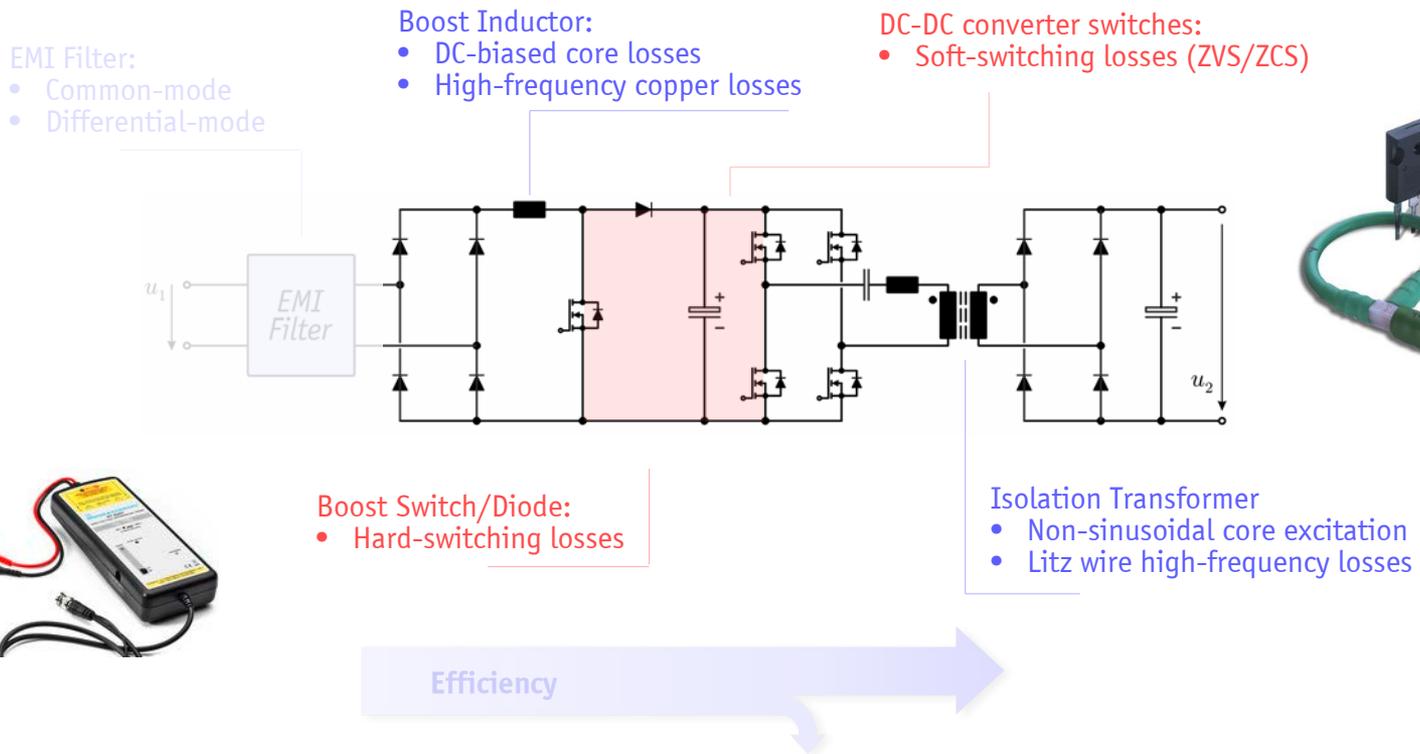
► Boost-type PFC with Isolated DC-DC Stage — Revisited

- Passive Components: Inductors, transformers, capacitors



► Boost-type PFC with Isolated DC-DC Stage — Revisited

- Passive Components: Inductors, transformers, capacitors
- Active Components: Switches, diodes



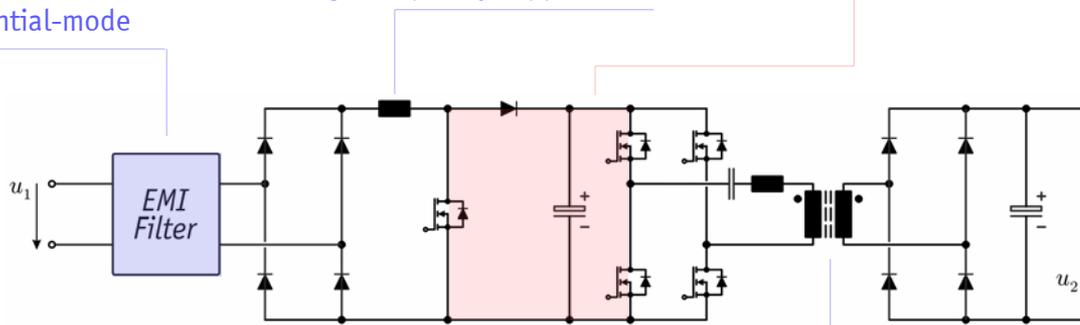
► Boost-type PFC with Isolated DC-DC Stage — Revisited

- **Passive Components:** Inductors, transformers, capacitors
- **Active Components:** Switches, diodes
- **System Level:** Efficiency, EMI compatibility

- EMI Filter:
- Common-mode
 - Differential-mode

- Boost Inductor:
- DC-biased core losses
 - High-frequency copper losses

- DC-DC converter switches:
- Soft-switching losses (ZVS/ZCS)



- Boost Switch/Diode:
- Hard-switching losses

- Isolation Transformer
- Non-sinusoidal core excitation
 - Litz wire high-frequency losses



Today's Measurement Concepts

...in power electronic systems:
Passive components
Active components
System level

► Measurement of Core Losses

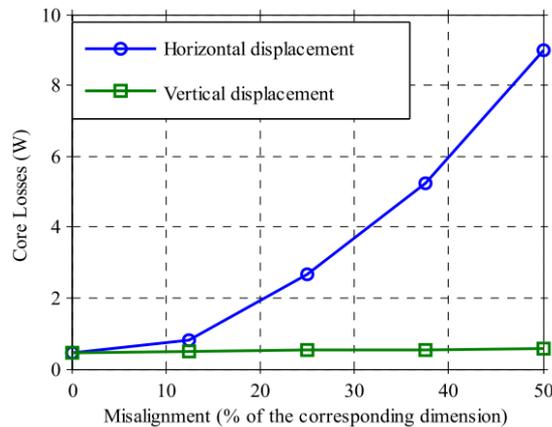
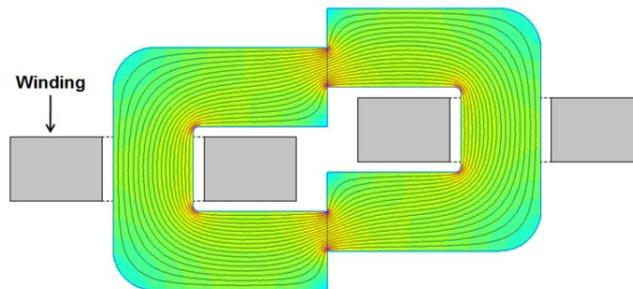
- Datasheet provided parameters are only valid for sinusoidal excitation
- **Differences of up to two times in core losses with respect to calculated values have been reported**



- Improved core loss estimation methods for non-sinusoidal excitation should be considered
- ... or a relatively simple core-loss estimation system can be built.

► Measurement of Core Losses

- Increase of core losses due to misalignment of tape wound cores



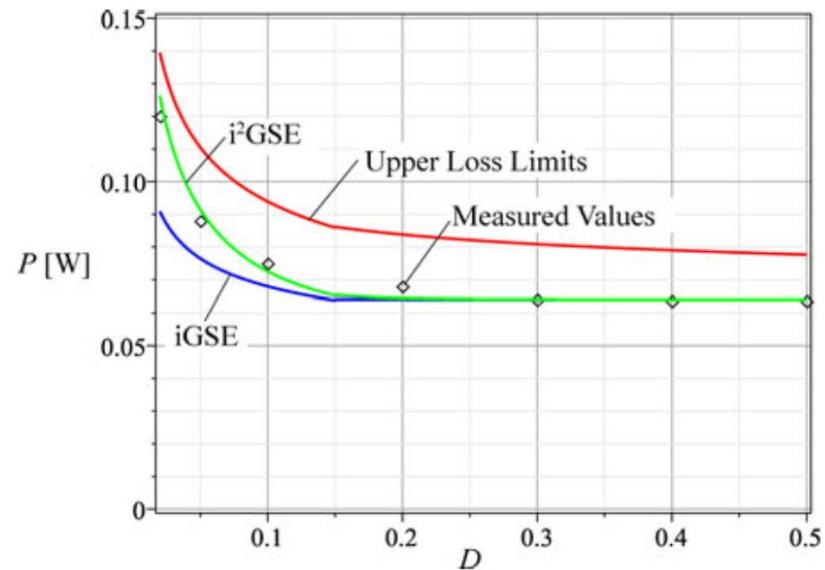
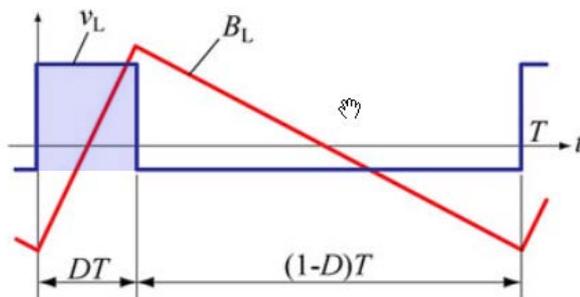
Source: B. Cougo 2011
 "Increase of Tape Wound Core Losses due to Interlamination Short Circuits and Orthogonal Flux Components"

- Core losses are extremely sensitive to horizontal misalignment

► Core Loss Measurement Equipment

- Characterization of the core losses in inductor for variable duty cycle
- The losses based on the i^2GSE match the measured losses for variable duty cycle

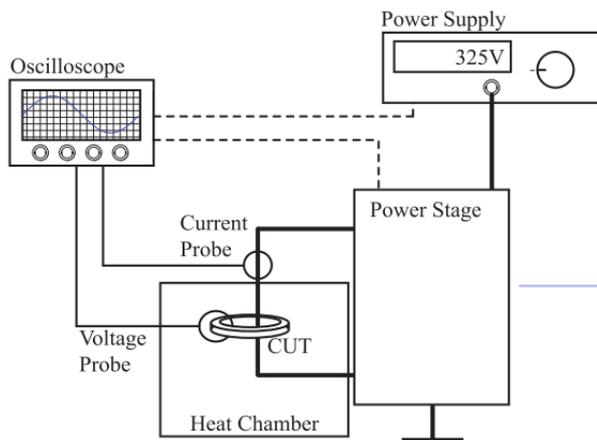
Source: J. Mühlethaler 2012
 "Improved Core-Loss Calculation for Magnetic Components Employed in Power Electronic Systems"



- Improved core loss estimation methods should be used for calculation of core losses in PE circuits
- **A simple testbench can be built in order to characterize core materials for a specific application**

► Core Loss Measurement Equipment

- Full-bridge structure generates typical excitations found in power electronic converters
- External power supply adjusts the voltage amplitude



Source: J. Mühlethaler 2010

“Core Losses under DC Bias Condition based on Steinmetz Parameters”



Power stage based on full-bridge structure

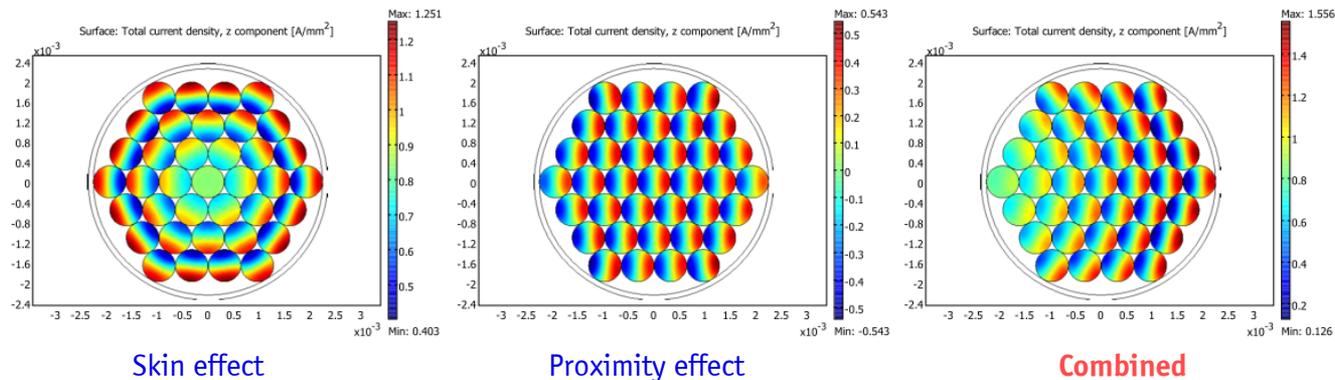
- Voltage and current are measured simultaneously to extract the core's BH loop

► High Frequency Effects in Copper Conductors

- Skin and proximity effects arise from the conduction of high-frequency currents in copper cond.

Source: I. Villar 2010

“Multiphysical Characterization of Medium-Frequency Power Electronic Transformers”

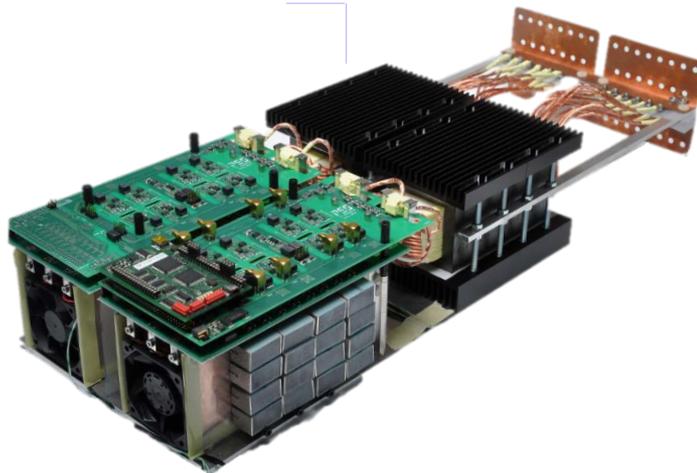


- **Not accounting for high-frequency effects results in low accuracy in converter loss estimation**
- Manufacturing of high quality litz wire is complex and costly

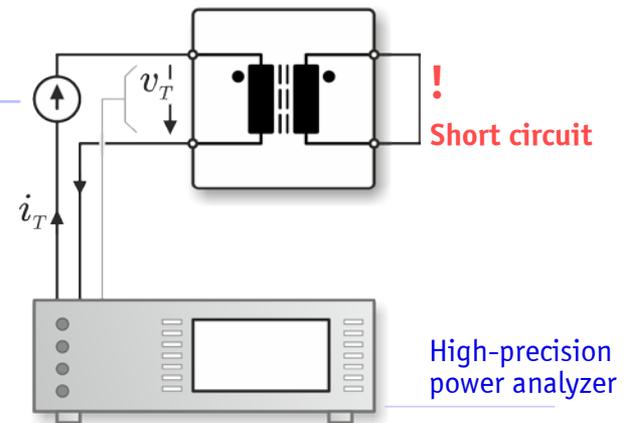
► Copper Loss Measurement Equipment

- The transformer must be short circuited on its secondary terminal with a very low resistive path
- An AC current source provides the high-frequency current with the required RMS value

High-current high-frequency
AC source



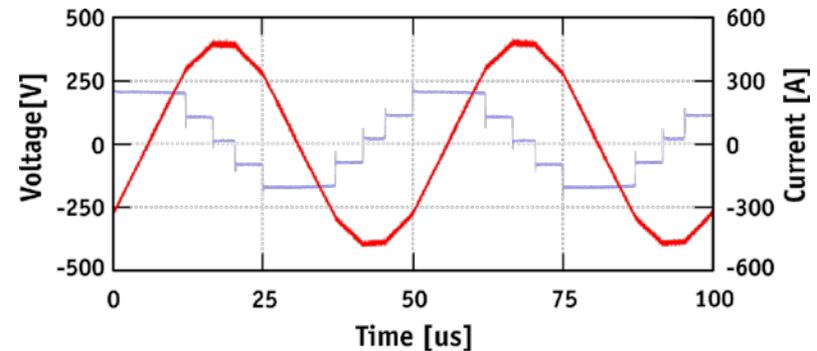
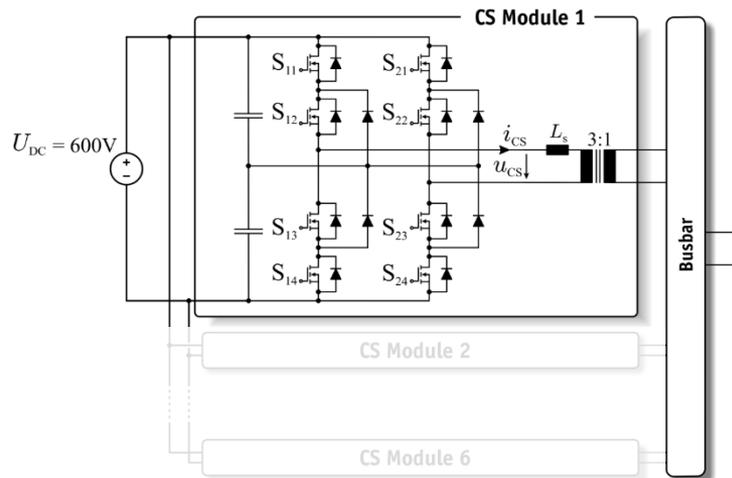
Transformer under test



- Since the power delivered is mainly reactive a high power analyzer is utilized to measure the total losses

► Copper Loss Measurement Equipment

- The current source: 5-level NPC bridges feeding an inductive load through a step-down transformer
- Mid-point voltage balancing required for stable operation

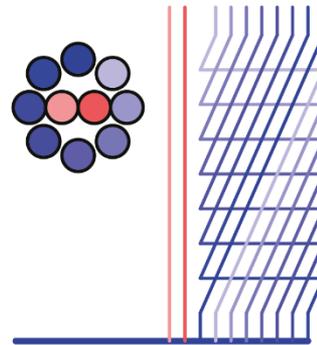
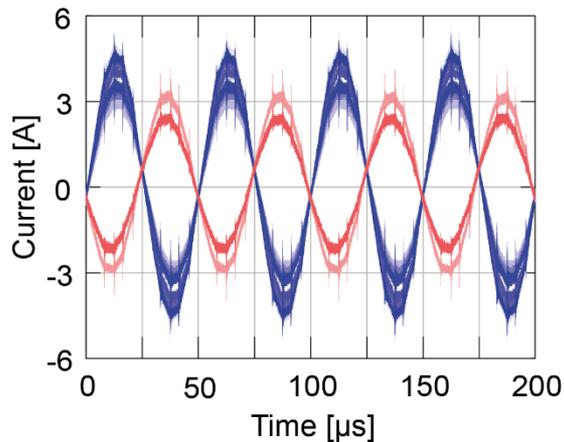


Source: Ch. Gammeter 2012
"Medium Frequency High Current Source for Testing Interconnections in High-Power Converters"

- **Minimum THD modulation achieves low harmonic distortion in output current**

► Copper Loss Measurement — Litz Wire Bundles

- Case study: Litz wire (tot. 9500 strands of 71 μ m each) with 10 sub-bundles
- Current distribution in internal litz wire bundles depends strongly on interchanging strategy



Source: G. Ortiz 2013
"Medium Frequency Transformers for Solid-State
Transformer Applications — Design and
Experimental Verification"

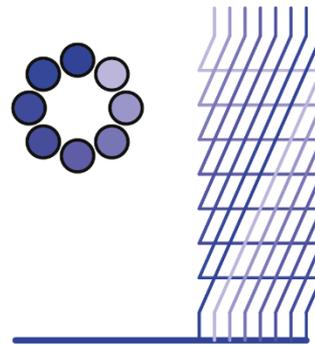
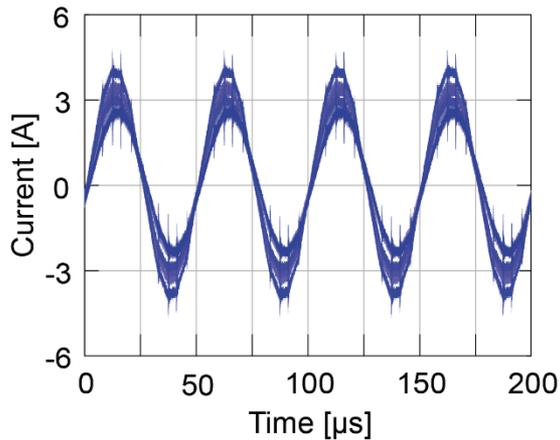


10 bundles 950 with 71 μ m strands each

- Total copper losses for 10 bundles: 438W

► Copper Loss Measurement — Litz Wire Bundles

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- Current distribution in internal litz wire bundles depends strongly on interchanging strategy



Source: G. Ortiz 2013
"Medium Frequency Transformers for Solid-State Transformer Applications — Design and Experimental Verification"



10 bundles 950 with 71 μ m strands each

- Total copper losses for 10 bundles: 438W
- **Total copper losses for 8 bundles: 353W**

Today's Measurement Concepts

...in power electronic systems:
Passive components
Active components
System level

► Switching Loss Measurement — Current Sensing

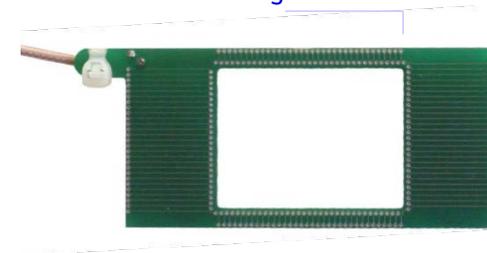
- High bandwidth (tens of MHz) and (in most cases) isolated transducer

- Current transformer
- Rogowski coil (PCB)

Rogowski coil
Source: www.pemuk.com



PCB Rogowski coil



Planar current transformer



Coaxial current shunt
Source: www.ib-billmann.de

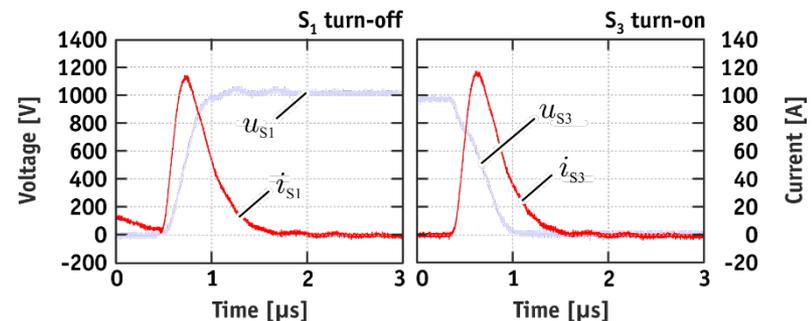
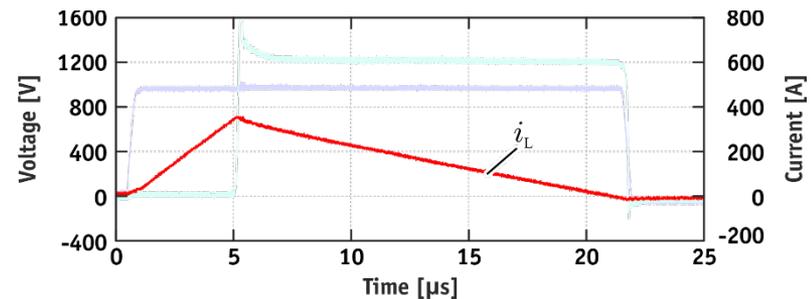
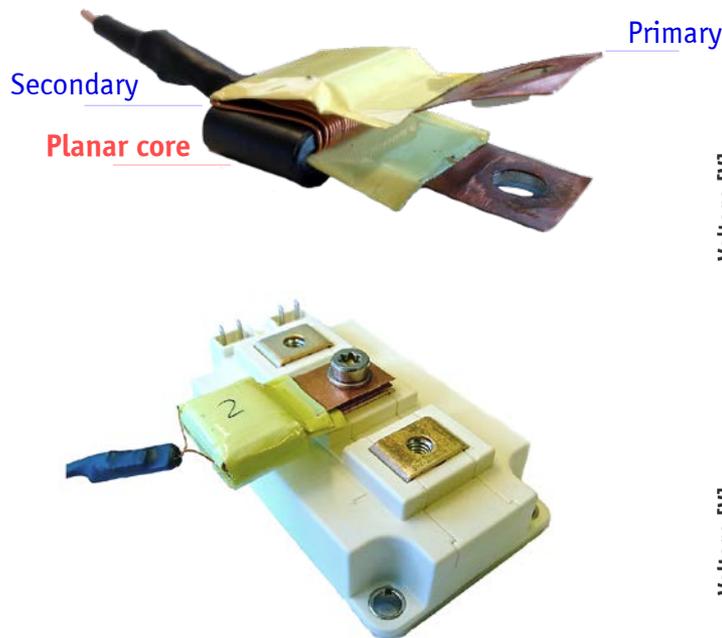


- High bandwidth coaxial current shunt (expensive, non-isolated)

► Switching Loss Measurement — Current Sensing

- Current transformers:

- High bandwidth isolated planar current transformer built in-house with standard components
- Designed for pulse operation → small construction



- Very easy to manufacture!

► Switching Loss Measurement — Current Sensing

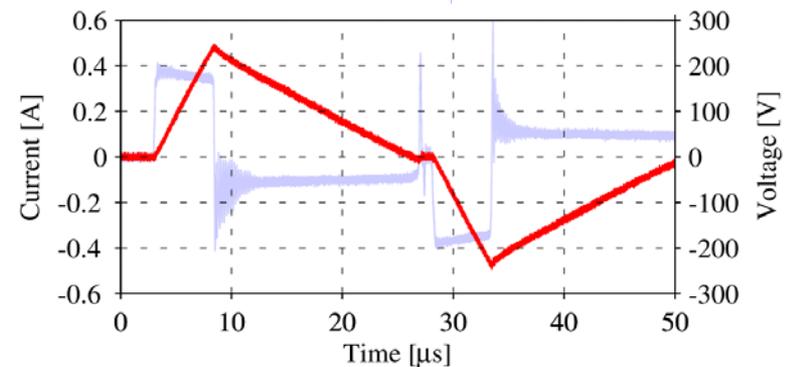
- Rogowski Coils

- High bandwidth, isolated Rogowski coil **built with standard PCB**
- For switching loss measurement, the integration is preferably done in post-processing

PCB Rogowski coil placed
on an IGBT module



Resulting voltage output
and **integrated signal**



Source: Y. Lobsiger 2011

*“Decentralized Active Gate Control for Current
Balancing of Parallel Connected IGBT Modules”*

- Extremely low effect on power circuit
- **Very well suited for measurement in IGBT modules**

► Switching Loss Measurement — Current Sensing

- Current shunt

- Exceptionally high bandwidth (in the GHz range) and direct voltage output
- PCB soldered shunts offer the possibility to measure switches with virtually any package



Coaxial current shunt

Source: www.ib-billmann.de



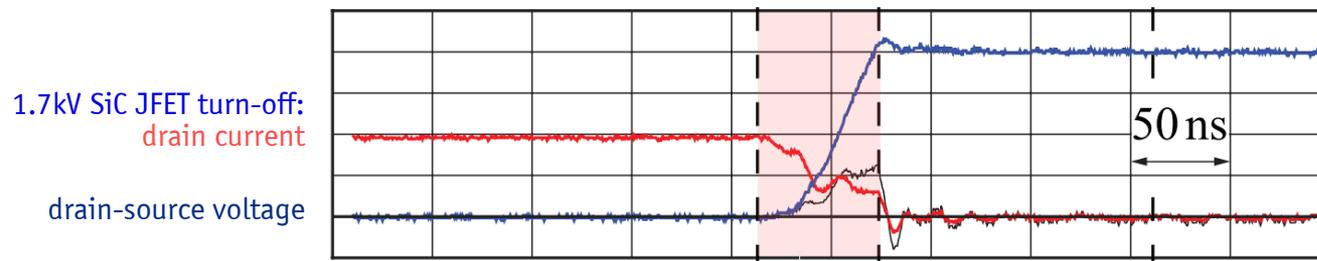
Source: R. Burkart 2013

*“Comparative Evaluation of SiC and Si PV Inverter Systems
Based on Power Density and Efficiency as
Indicators of Initial Cost and Operating Revenue”*

- Typically expensive and non-isolated → **requires an oscilloscope with isolated channels**
- Alternative constructions with SMD resistors also possible

► Switching Loss Measurement — Deskew

- MOSFET and SiC technology feature ultra high switching speeds in the tens of nanoseconds range
- Light takes about 3.3ns to travel 1 meter → different cable lengths can lead to meas. inaccuracies



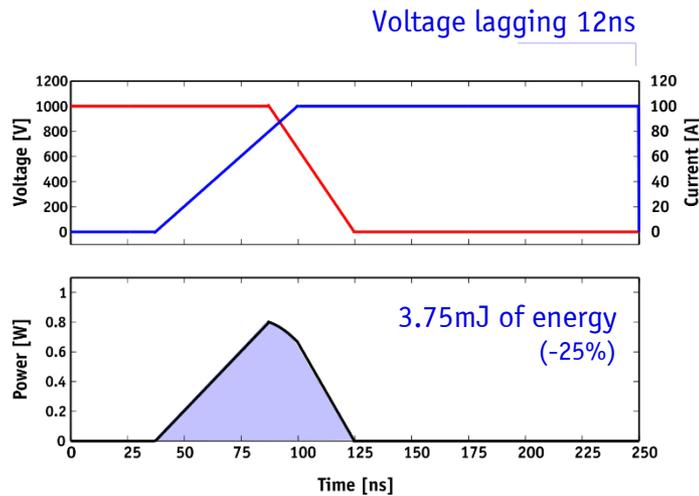
Source: R. A. Friedemann 2012
*"Design of a Minimum Weight Dual Active Bridge Converter
for an Airborne Wind Turbine System"*

- Specially critical if the voltage/current measurement is not done passively (e.g. diff probes)

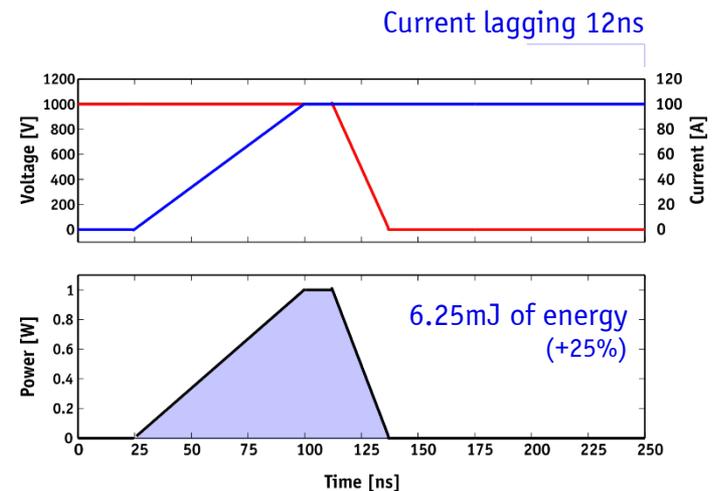
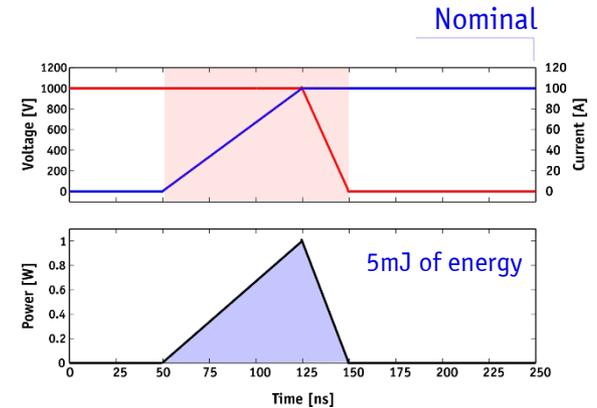
► Switching Loss Measurement — Deskew

- Simplified example case:

- Switching 100A with a 1000V DC-link
- Unipolar-type semiconductor, i.e. **no tail current** with a **linear parasitic capacitance** and ideal circuit layout (no parasitic stray inductance, hence **no switching overshoot**)
- Switching time: 100ns

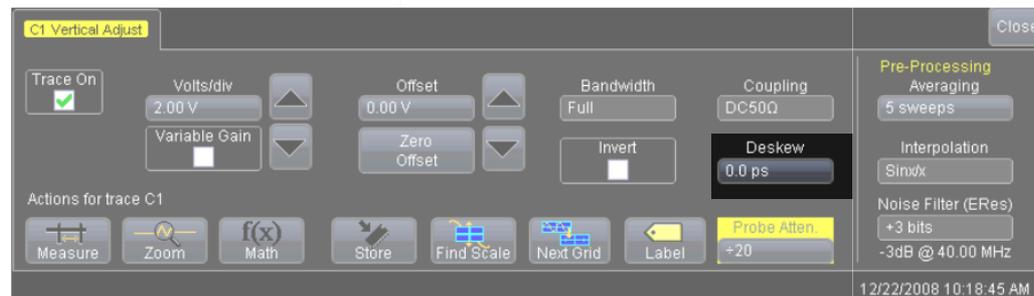


- Deviations of $\pm 25\%$ on measured energy with only a 12ns deskew



► Switching Loss Measurement — Deskew

- Correcting deskew mismatch can be done directly in modern oscilloscopes
- Example: Lecroy Wavesurfer MXs-B oscilloscope



Source: www.teledynelecroy.com

- Or in post-processing (e.g. with Matlab)
- **In all cases, the deskew must be properly measured beforehand**

Today's Measurement Concepts

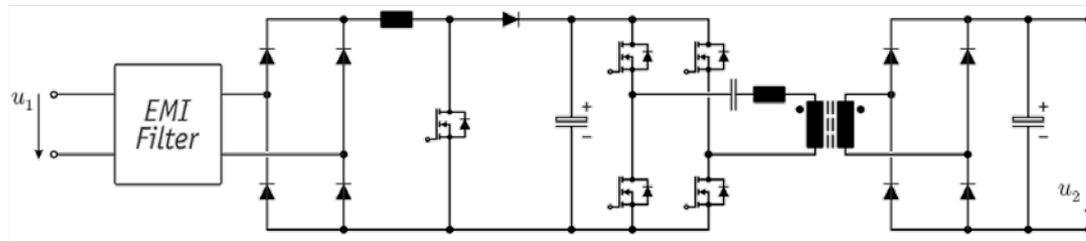
*...in power electronic systems:
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Active components
System level*

► Assessing System's Performance — Efficiency

- Efficiency constitutes one of the systems primary performance indices
- The measurement of efficiency is typically done in one of two ways:

- Measurement of input and output power
- Measurement of input or output power and power losses

$$\eta = \frac{P_{out}}{P_{in}} = \frac{P_{out}}{P_{out} + P_{loss}}$$



- The desired accuracy of the efficiency measurement will determine which method should be used

► Assessing System's Performance — Efficiency

- Input and output power measurement

- **Power analyzer:** Yokogawa WT3000
- Reading accuracy: 0.02%
- Range accuracy: 0.04%



www.yokogawa.com

- **Table multimeter:** Agilent 34401
- Reading accuracy: 0.005% @ 100mV
- Range accuracy: 0.0035% @ 100mV



www.agilent.com

Source: Th. Schröter 2011
 "Aspects and Considerations for Accurate Measurement of Very High Efficiency"

▶ Assessing System's Performance — Efficiency

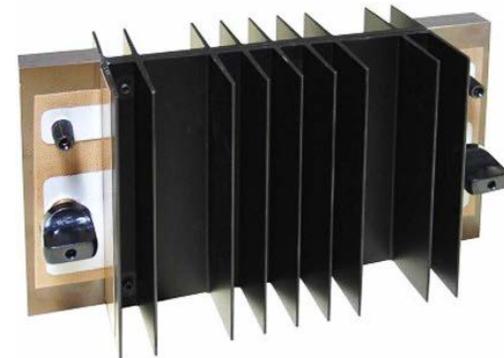
- Input and output power measurement

- **Handheld multimeter:** Fluke 80 series V
- Reading accuracy: 0.3% @ 600mV



www.fluke.com

- **Shunt resistor (curr. meas.):** Burster 1282
- Shunt resistance: 1m Ω (1mV/A)
- Resistance tolerance: 0.02%
- Temperature coefficient: 0.001 %/ $^{\circ}$ K



www.burster.com

Source: Th. Schröter 2011

"Aspects and Considerations for Accurate Measurement of Very High Efficiency"

▶ Assessing System's Performance — Efficiency

- Measurement situation example:

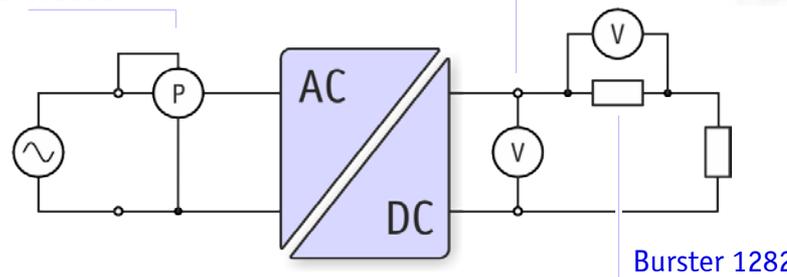
- Input power (AC side): **Yokogawa WT3000**
- Output power (DC side): **Agilent 34401 (voltage)**
Burster 1282 & Agilent 34401 (current)



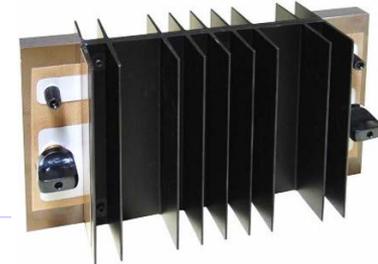
Yokogawa WT3000



Agilent 34401



Burster 1282

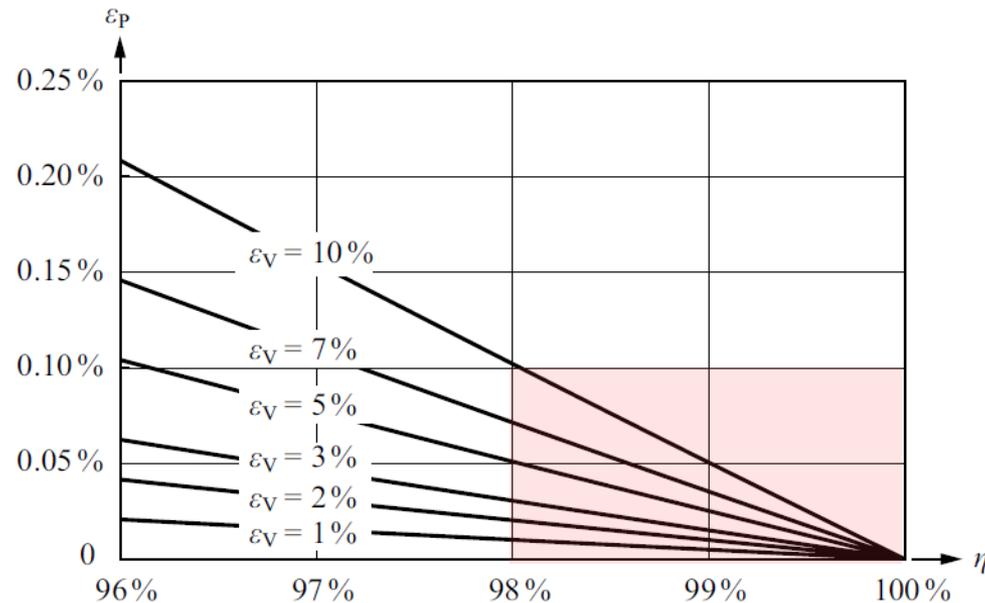


- **Achieved power measurement accuracy: $\pm 0.107\%$**

Source: Th. Schröter 2011
"Aspects and Considerations for Accurate
Measurement of Very High Efficiency"

► Assessing System's Performance — Efficiency

- Maximum permissible relative error in the power measurement for the determination of the losses with a max. relative error of in dependence on the efficiency



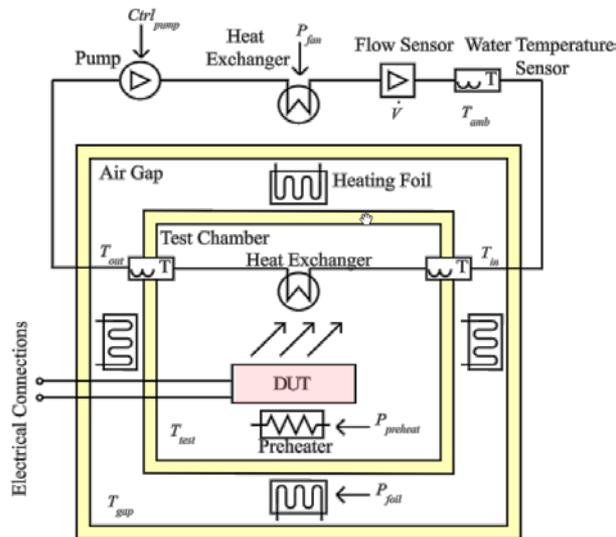
Source: J.W. Kolar 2012
"Extreme Efficiency Power Electronics"

- The power measurement accuracy must be extremely high when an accurate efficiency meas. is desired

► Assessing System's Performance — Efficiency

- Calorimetric direct power loss measurement

- Converter placed in a controlled-temperature double-jacketed chamber
- A water-cooled heat exchanger extracts the heat generated by the converter
- The power extracted through the water-cooling circuit corresponds to the losses gen. by the conv.



Source: D. Christen 2010
"Calorimetric Power Loss Measurement for
Highly Efficient Converters"

Calorimeter manufactured
by enertronics GmbH

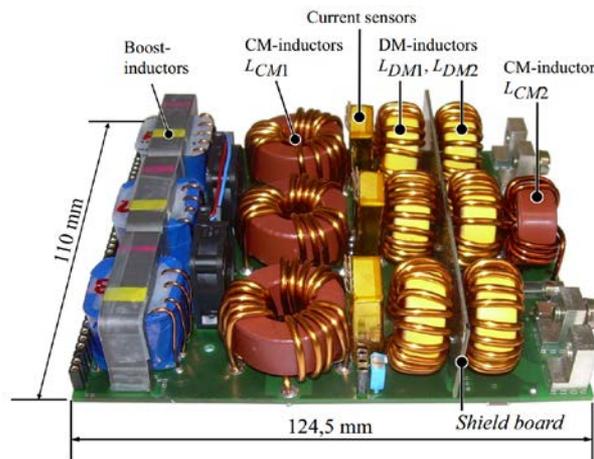


enertronics
www.enertronics.ch

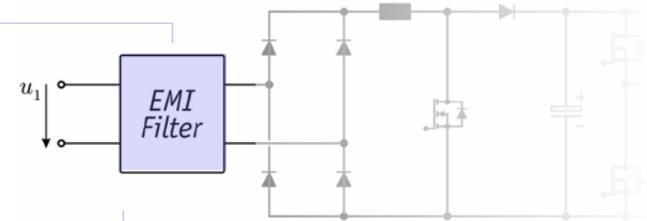
- Accuracy higher than $\pm 1\text{W}$ up to 100W of losses (e.g. for a 1kW converter $\rightarrow \pm 0.1\%$ accuracy)

► Assessing System's Performance — EMI Compatibility

- The performance of the EMI filter is split into:
 - Differential-mode rejection and
 - Common-mode rejection



Source: M. Hartmann 2010
 "EMI Filter Design for High Switching Frequency
 Three-Phase/Level PWM Rectifier Systems"



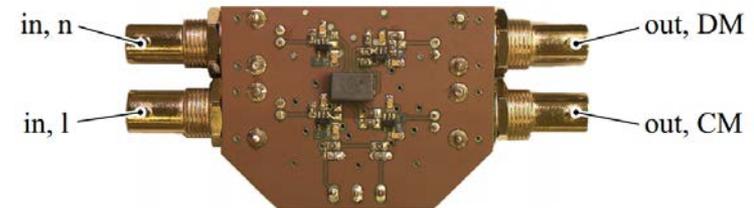
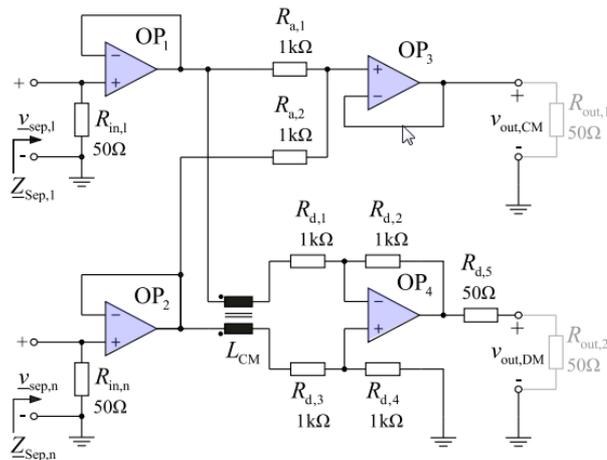
Differential-mode filter

Common-mode filter

- **These two parameters must be separated by a dedicated circuit**
- This allows to identify and correct possible incompatibilities with the respective EMI directives

► Assessing System's Performance — EMI Compatibility

- Simple active circuit for separation of CM and DM noise
- Requires 4 OP-amps and passive components



Source: S. Schroth 2014
"Analysis and Practical Relevance of CM/DM EMI
Noise Separator Characteristics"

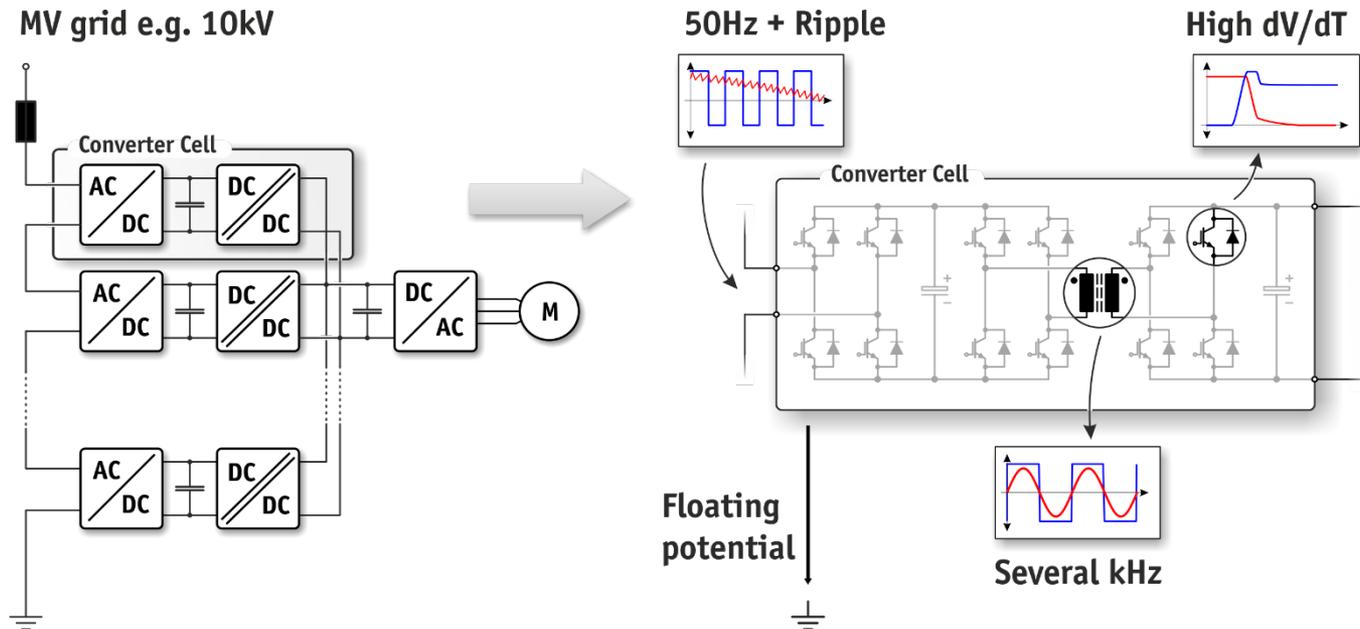
- Achieves $DM_{TR}/CM_{RR} > 51$ dB and $CM_{TR}/DM_{RR} > 47$ dB for frequencies up to 10MHz

Future Technologies

Smart Grid / DC Distribution
Highly Integrated Microelectronics

► Future Traction Vehicles Based on SST Technology

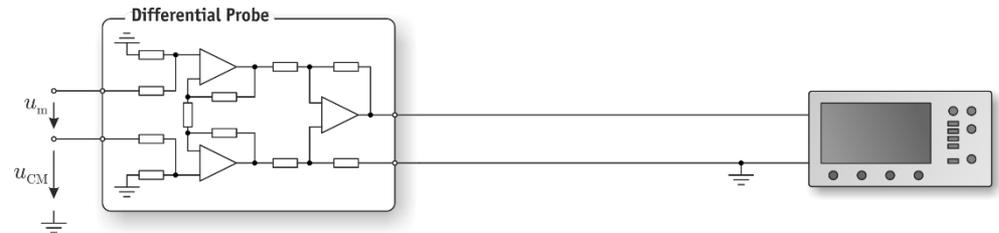
- Typical measurements performed during testing and commissioning of power electronic converters



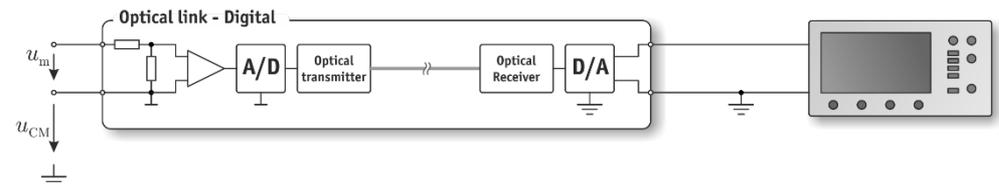
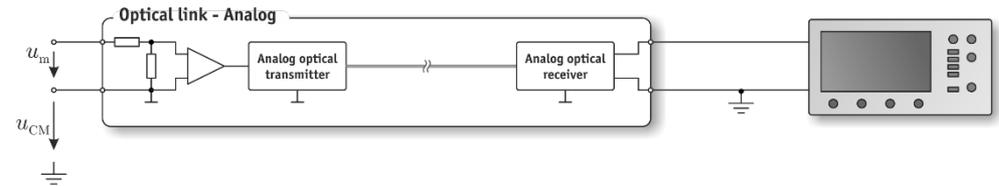
- **Floating potentials:** Up to tens of kilovolts and tens of kilovolts/microsecond
- **Voltages / currents:** From millivolts to kilovolts, from amps to kiloamps, **DC to tens of MHz**

► State-of-the-Art Isolated Voltage Measurement

- Basic types
 - Differential probes



- Optically isolated systems (analog link / digital link)



- Drawback: probe combines isolation and measurement

► State-of-the-Art Isolated Current Measurement

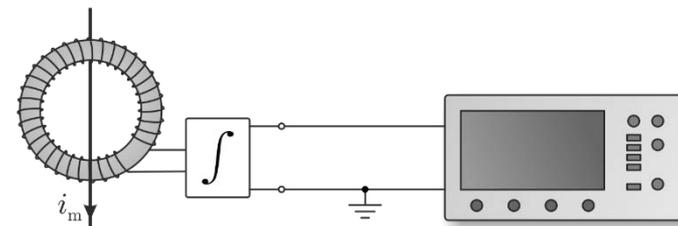
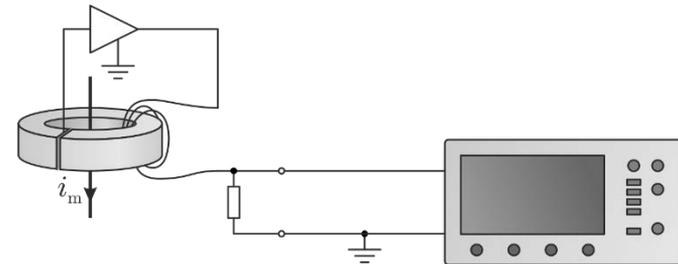
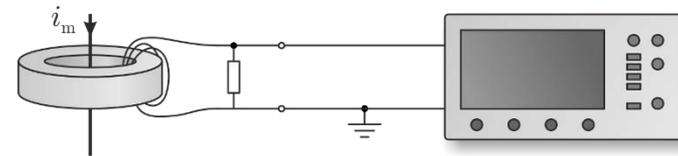
- Basic types
 - Current transformers



- Current compensated transformers (clamp-on current probes)



- Rogowski coils

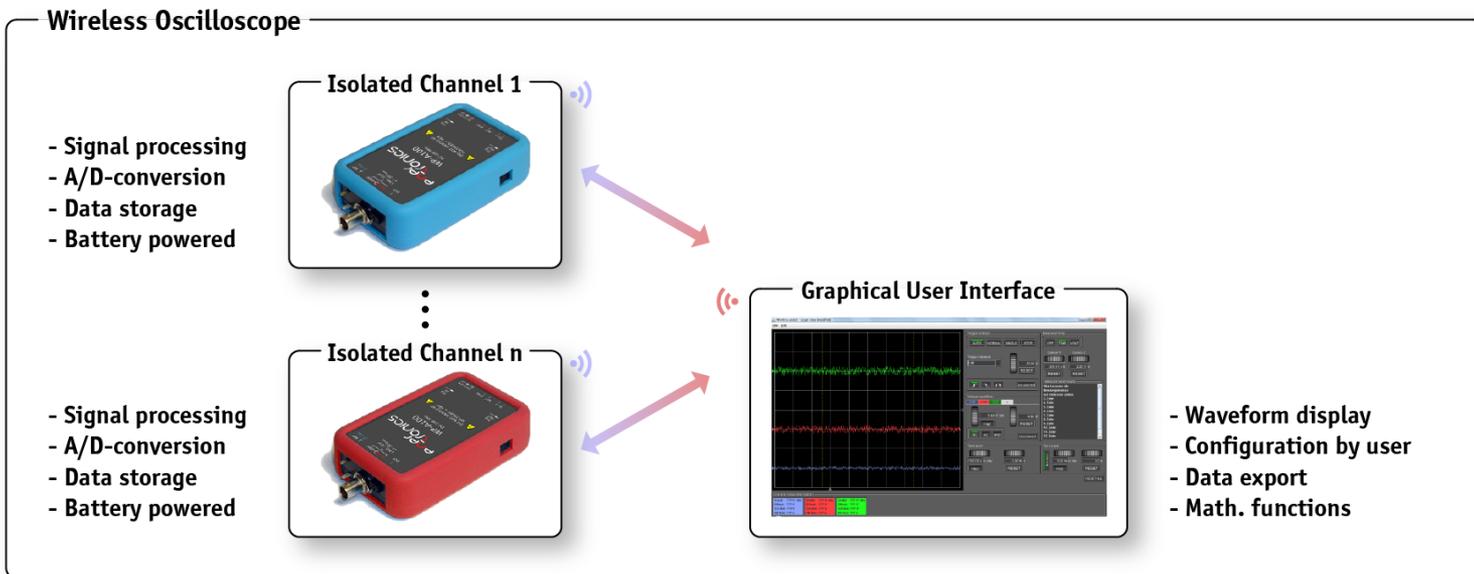


- Drawback: combination of isolation and measurement

► Wireless Oscilloscope – Basic Idea

- Provide the isolation at a different position in the measurement chain

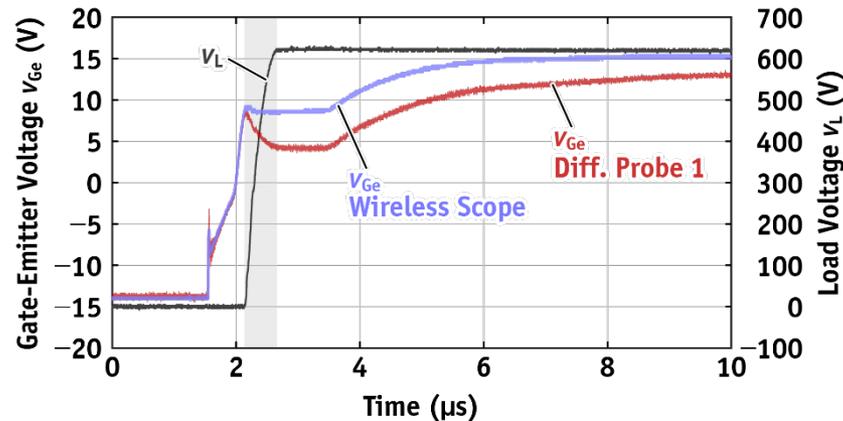
- Separate data acquisition (channels) and user interface
- No need for isolated probes / sensors
- No need for an additional oscilloscope



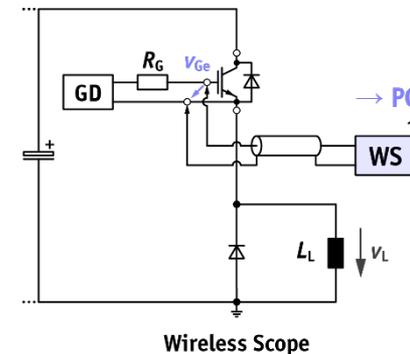
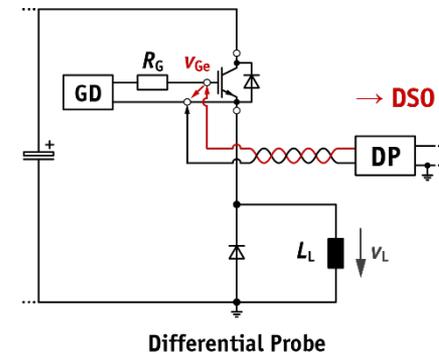
- System overview of a 100MHz wireless channel oscilloscope

► Isolated Voltage Measurement

- Setup consist of measurement of high side gate signal on a half-bridge-type structure
 - The differential probe exhibits strong CM error during high dv/dt



- The Wireless Scope features no visible CM error



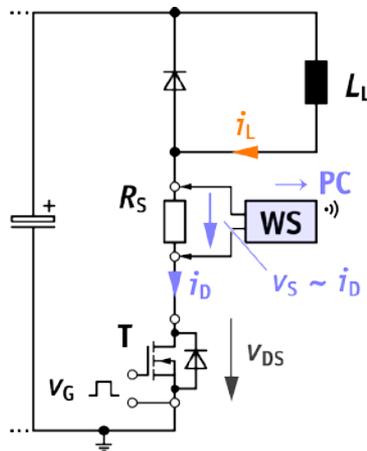
► Isolated Current Measurement

MOSFET drain current

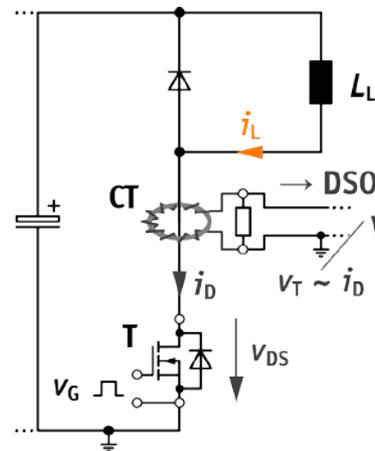
- Floating reference voltage
- High bandwidth current transients (turn-on / turn-off)

Measurement setup

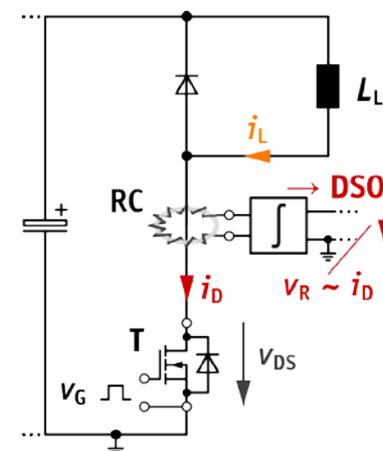
- 0.1 Ohm shunt & Wireless Scope
- Current transformer
- Rogowski coil



Shunt & Wireless Scope

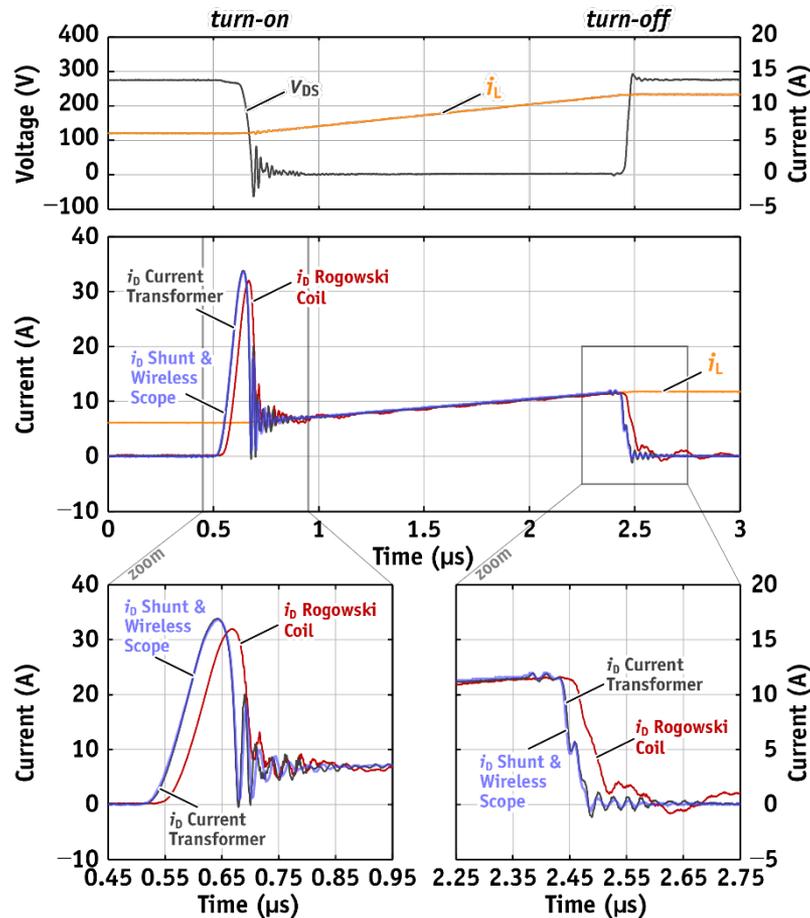


Current Transformer



Rogowski Coil

► Isolated Current Measurement 2 — Results



Rogowski Coil

- Delay
- Limited bandwidth
- Ringing due to CM transients
- Limited isolation voltage

Current Transformer

- High bandwidth
- No apparent CM error
- High-pass characteristic (no DC)
- Limited isolation voltage

Shunt & Wireless Scope

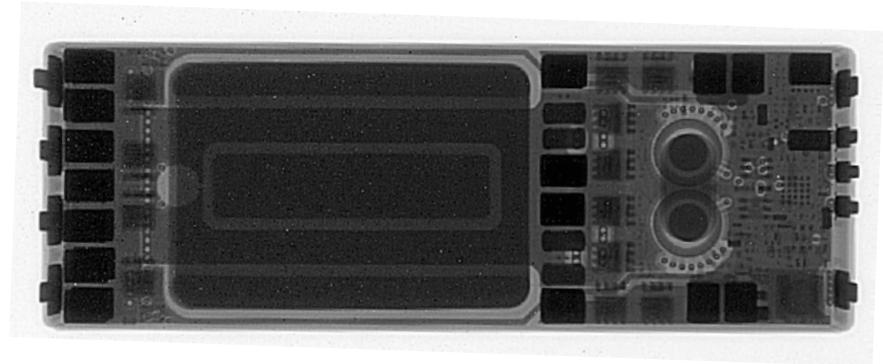
- High bandwidth
- No apparent CM error
- DC – 100 MHz
- No intrinsic limitation on isolation voltage

Future Technologies

Smart Grid / DC Distribution
Highly Integrated Microelectronics

► Example Microelectronics Highly Integrated Converter

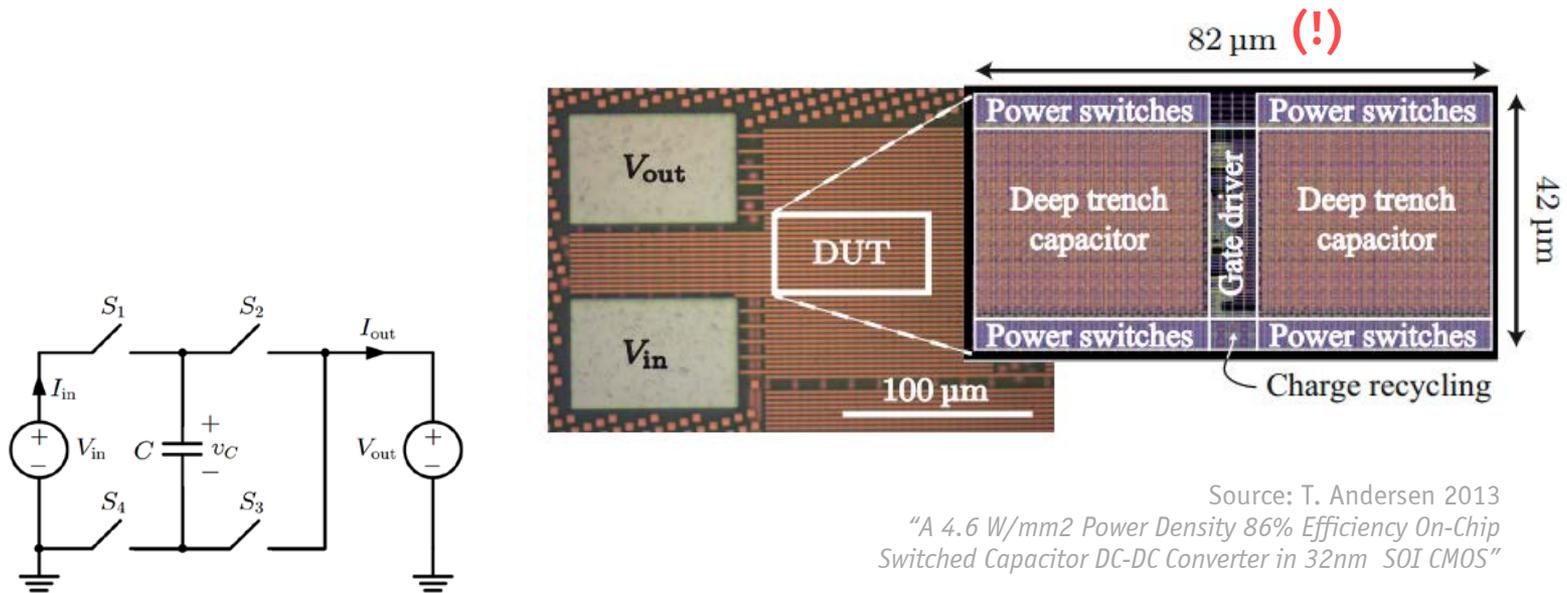
- Isolated (4kV) DC-DC converter with power output up to 1.7kW



- How to test the circuit? How to measure internal signals? How to characterize switching performance? How to characterize magnetics performance?

► Example of Power Supply on Chip

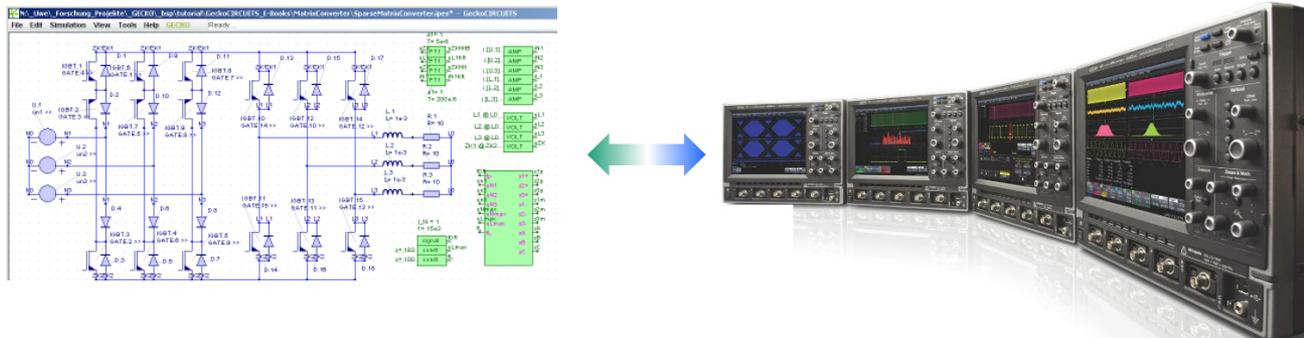
- Switched capacitor converter with $4.6\text{W}/\text{mm}^2$ and 86% efficiency



- How to test the circuit? How to measure internal signals? How to characterize switching performance? How to characterize capacitor performance?

► Future Micro Power Electronic Solutions

- Merge simulation and measurement to create a "simulation-augmented" environment



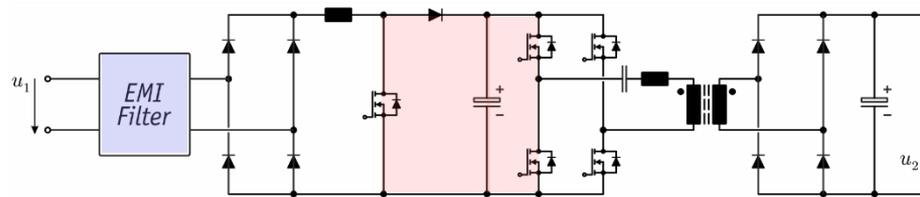
- Link between these two enables to supervise internal quantities of the experimental hardware

Summary / Outlook



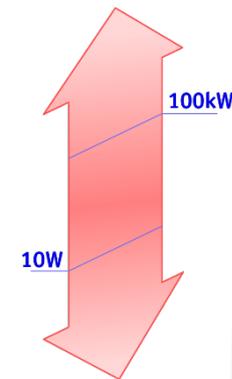
► Measurement in Today's Power Electronics

- Design of power electronics circuit that fulfills given specifications
 - Components: Passives, Actives
 - System: Efficiency, EMI



► Measuring Future Power Electronics

- High-power medium-frequency electric power systems-oriented
 - High common-mode, high isolation, high bandwidth
 - **Wireless measurement systems**
- Microelectronics, highly integrated solutions:
 - Simulation augmented measurement concepts



Thank You!

Questions?

